## Notice of References Cited Application/Control No. 10/089,178 Applicant(s)/Patent Under Reexamination HIBINO ET AL. Examiner Devona E. Faulk Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,661,811	08-1997	Huemann et al.	381/309
	В	US-			
	O	US-			
	ם	US-			
	E	US-			
	F	US-			
	G	US-			
	Η	US-			
		US-			
	7	US-			
	К	US-			
	L	US			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	GB 2246688 A	02-1992	United Kingdom	SMITH et al.	H04B 1/10
	0					
	Р					
	α					
	R				·	
	S.					
	Т			·		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.